Applicant: Chi-Wei Huang, et al.

Serial No.: 10/761,881

Attorney Docket No.: 67,200-1225

## IN THE CLAIMS

Please cancel claims 13-16.

Please amend claims 1-9 as follows.

 (Currently amended) An insert ring <u>assembly</u> for a process chamber, comprising:

an insert ring having a ring body defining a central ring opening; and an annular step having an upper step surface provided on said ring body and spaced-apart from said central ring opening; and

a shadow ring encircling said insert ring and extending beyond said upper step surface of said insert ring.

- 2. (Currently amended) The insert ring <u>assembly</u> of claim 1 wherein said ring body comprises silicon.
- 3. (Currently amended) The insert ring assembly of claim 1 wherein said ring body has a ring body thickness of about 3.5 mm.
- 4. (Currently amended) The insert ring <u>assembly</u> of claim 3 wherein said ring body comprises silicon.
- 5. (Currently amended) The insert ring <u>assembly</u> of claim 1 wherein said step has a step thickness of about 1.5 mm.
- 6. (Currently amended) The insert ring <u>assembly</u> of claim 1 wherein said process chamber comprises etching process chamber.

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- 7: (Currently amended) The insert ring <u>assembly</u> of claim 5 wherein said ring body has a ring body thickness of about 3.5 mm.
- 8. (Currently amended) The insert ring <u>assembly</u> of claim 7 wherein said ring body comprises silicon.
- 9. (Currently amended) An insert ring assembly for a process chamber, comprising:

a wafer support for supporting a wafer;

an insert ring encircling said wafer support, said insert ring comprising a ring body defining a central ring opening and an annular step <a href="having an upper step surface">having an upper step surface</a> provided on said ring body and spaced-apart from said central ring opening; and

a generally perpendicular flow space defined between said insert ring and said wafer support; and

a shadow ring encircling said insert ring and extending beyond said upper step surface of said insert ring.

- 10. (Original) The insert ring assembly of claim 9 wherein said ring body comprises silicon.
- 11. (Original) The insert ring assembly of claim 9 wherein said ring body has a ring body thickness of about 3.5 mm and said step has a step thickness of about 1.5 mm.

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12. (Original) The insert ring of claim 9 wherein said process chamber comprises etching process chamber.

## 13-16 (Canceled)

17. (Withdrawn) A method of preventing formation of polymer residues on an inner surface of an insert ring encircling a substrate support during processing of a substrate on the substrate support, comprising the step of:

providing a generally perpendicular flow space between said insert ring and said substrate support by providing a generally step-shaped cross-sectional profile to said insert ring.

- 18. (Withdrawn) The method of claim 17 wherein said insert ring comprises a ring body defining a central ring opening and an annular step provided on said ring body and spaced-apart from said central ring opening.
- 19. (Withdrawn) The method of claim 17 wherein said insert ring comprises quartz.
- 20. (Withdrawn) The method of claim 19 wherein said insert ring comprises a ring body defining a central ring opening and an annular step provided on said ring body and spaced-apart from said central ring opening.